

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
ISHIBASHI ET AL.

Examiner

RAKESH K. DHINGRA

Art Unit

1792

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0025607	10-2001	Lebar et al.	118/723.0MW
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 11-260594	09-1999	Japan	Watanabe et al	H05H 1/46
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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